



RF Power LDMOS Transistor

N-Channel Enhancement-Mode Lateral MOSFET

This 56 W RF power LDMOS transistor is designed for cellular base station applications requiring very wide instantaneous bandwidth capability covering the frequency range of 2110 to 2200 MHz.

2100 MHz

- Typical Single-Carrier W-CDMA Performance: $V_{DD} = 28$ Vdc, $I_{DQ} = 1600$ mA, $P_{out} = 56$ W Avg., Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF.

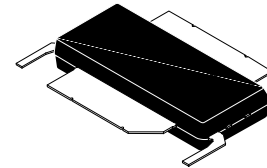
Frequency	G_{ps} (dB)	η_D (%)	Output PAR (dB)	ACPR (dBc)	IRL (dB)
2110 MHz	17.0	30.0	6.9	-35.2	-11
2140 MHz	17.6	30.8	6.9	-34.2	-16
2170 MHz	17.9	31.8	6.8	-33.5	-25
2200 MHz	18.2	32.9	6.6	-32.9	-15

Features

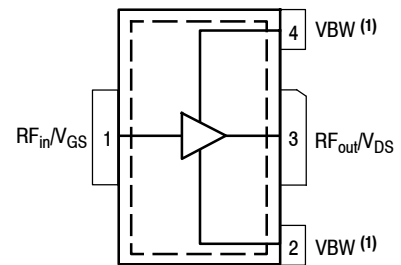
- Designed for wide instantaneous bandwidth applications
- Greater negative gate-source voltage range for improved Class C operation
- Able to withstand extremely high output VSWR and broadband operating conditions
- Optimized for Doherty applications

A2T21S260W12NR3

**2110–2200 MHz, 56 W AVG., 28 V
 AIRFAST RF POWER LDMOS
 TRANSISTOR**



**OM-880X-2L2L
 PLASTIC**



(Top View)

Note: Exposed backside of the package is the source terminal for the transistor.

Figure 1. Pin Connections

- Device can operate with V_{DD} current supplied through pin 2 and pin 4.

Table 1. Maximum Ratings

Rating	Symbol	Value	Unit
Drain-Source Voltage	V_{DSS}	-0.5, +65	Vdc
Gate-Source Voltage	V_{GS}	-6.0, +10	Vdc
Operating Voltage	V_{DD}	32, +0	Vdc
Storage Temperature Range	T_{stg}	-65 to +150	°C
Case Operating Temperature Range	T_C	-40 to +125	°C
Operating Junction Temperature Range (1,2)	T_J	-40 to +225	°C

Table 2. Thermal Characteristics

Characteristic	Symbol	Value (2,3)	Unit
Thermal Resistance, Junction to Case Case Temperature 72°C, 56 W Avg., W-CDMA, 28 Vdc, $I_{DQ} = 1600$ mA, 2155 MHz	$R_{\theta JC}$	0.24	°C/W

Table 3. ESD Protection Characteristics

Test Methodology	Class
Human Body Model (per JESD22-A114)	2
Charge Device Model (per JESD22-C101)	C3

Table 4. Moisture Sensitivity Level

Test Methodology	Rating	Package Peak Temperature	Unit
Per JESD22-A113, IPC/JEDEC J-STD-020	3	260	°C

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted)

Characteristic	Symbol	Min	Typ	Max	Unit
----------------	--------	-----	-----	-----	------

Off Characteristics

Zero Gate Voltage Drain Leakage Current ($V_{DS} = 65$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	10	μAdc
Zero Gate Voltage Drain Leakage Current ($V_{DS} = 32$ Vdc, $V_{GS} = 0$ Vdc)	I_{DSS}	—	—	5	μAdc
Gate-Source Leakage Current ($V_{GS} = 5$ Vdc, $V_{DS} = 0$ Vdc)	I_{GSS}	—	—	1	μAdc

On Characteristics

Gate Threshold Voltage ($V_{DS} = 10$ Vdc, $I_D = 320$ μAdc)	$V_{GS(th)}$	1.2	1.7	2.2	Vdc
Gate Quiescent Voltage ($V_{DD} = 28$ Vdc, $I_D = 1600$ mAdc, Measured in Functional Test)	$V_{GS(Q)}$	2.2	2.6	3.0	Vdc
Drain-Source On-Voltage ($V_{GS} = 10$ Vdc, $I_D = 3.2$ Adc)	$V_{DS(on)}$	0.1	0.17	0.3	Vdc

1. Continuous use at maximum temperature will affect MTTF.
2. MTTF calculator available at <http://www.nxp.com/RF/calculators>.
3. Refer to AN1955, *Thermal Measurement Methodology of RF Power Amplifiers*. Go to <http://www.nxp.com/RF> and search for AN1955.

(continued)

Table 5. Electrical Characteristics ($T_A = 25^\circ\text{C}$ unless otherwise noted) (continued)

Characteristic	Symbol	Min	Typ	Max	Unit
Functional Tests ⁽¹⁾ (In NXP Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 1600\text{ mA}$, $P_{out} = 56\text{ W Avg.}$, $f = 2170\text{ MHz}$, Single-Carrier W-CDMA, IQ Magnitude Clipping, Input Signal PAR = 9.9 dB @ 0.01% Probability on CCDF. ACPR measured in 3.84 MHz Channel Bandwidth @ $\pm 5\text{ MHz}$ Offset.					
Power Gain	G_{ps}	16.5	17.9	19.0	dB
Drain Efficiency	η_D	29.0	31.8	—	%
Output Peak-to-Average Ratio @ 0.01% Probability on CCDF	PAR	6.4	6.8	—	dB
Adjacent Channel Power Ratio	ACPR	—	-33.5	-31.0	dBc
Input Return Loss	IRL	—	-25	-8	dB

Load Mismatch (In NXP Test Fixture, 50 ohm system) $I_{DQ} = 1600\text{ mA}$, $f = 2140\text{ MHz}$, $12\ \mu\text{sec(on)}$, 10% Duty Cycle

VSWR 10:1 at 32 Vdc, 390 W Pulsed CW Output Power (3 dB Input Overdrive from 320 W Pulsed CW Rated Power)	No Device Degradation
---	-----------------------

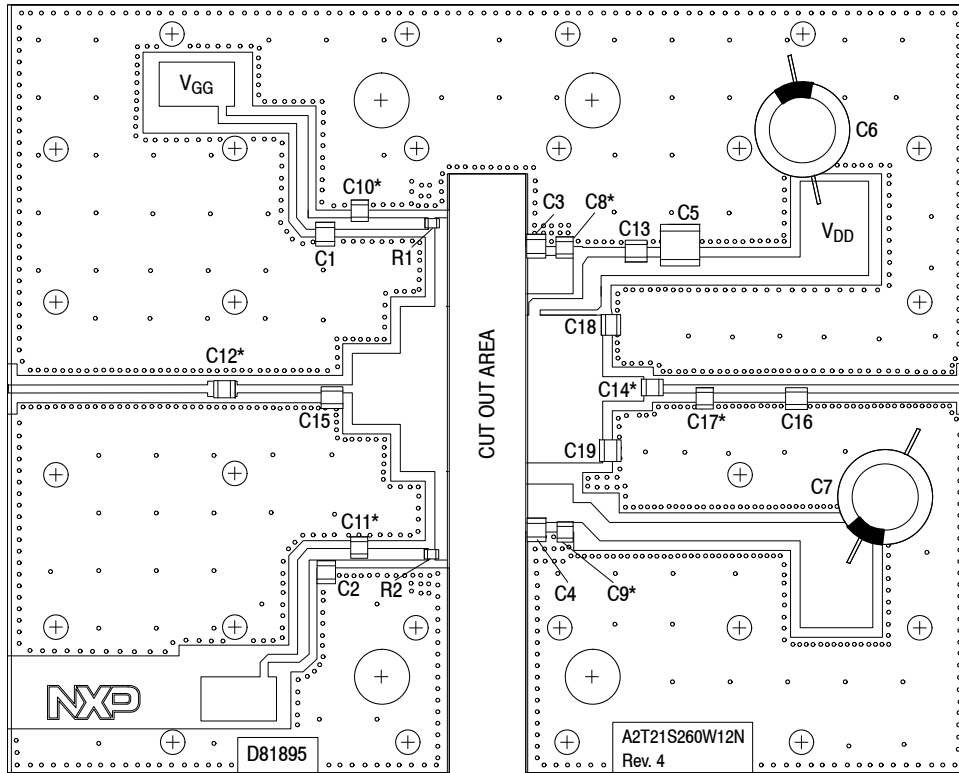
Typical Performance (In NXP Test Fixture, 50 ohm system) $V_{DD} = 28\text{ Vdc}$, $I_{DQ} = 1600\text{ mA}$, 2110–2200 MHz Bandwidth

P_{out} @ 1 dB Compression Point, Pulsed CW	P1dB	—	218	—	W
AM/PM (Maximum value measured at the P3dB compression point across the 2110–2200 MHz frequency range.)	Φ	—	-16	—	°
VBW Resonance Point (IMD Third Order Intermodulation Inflection Point)	VBW_{res}	—	100	—	MHz
Gain Flatness in 90 MHz Bandwidth @ $P_{out} = 56\text{ W Avg.}$	G_F	—	1.2	—	dB
Gain Variation over Temperature (-30°C to $+85^\circ\text{C}$)	ΔG	—	0.012	—	dB/°C
Output Power Variation over Temperature (-30°C to $+85^\circ\text{C}$)	$\Delta P1dB$	—	0.006	—	dB/°C

Table 6. Ordering Information

Device	Tape and Reel Information	Package
A2T21S260W12NR3	R3 Suffix = 250 Units, 56 mm Tape Width, 13-inch Reel	OM-880X-2L2L

1. Part internally matched both on input and output.



*C8, C9, C10, C11, C12, C14 and C17 are mounted vertically.

Figure 2. A2T21S260W12NR3 Test Circuit Component Layout

Table 7. A2T21S260W12NR3 Test Circuit Component Designations and Values

Part	Description	Part Number	Manufacturer
C1, C2	2.2 μ F Chip Capacitor	C3227X7R2A225M	TDK
C3, C4	4.7 μ F Chip Capacitor	C4532X7S2A475M230KB	TDK
C5	10 μ F Chip Capacitor	C5750X7S2A106M230KB	TDK
C6, C7	470 μ F, 63 V Electrolytic Capacitor	MCGPR63V477M13X26-RH	Multicomp
C8, C9, C10, C11, C12	6.2 pF Chip Capacitor	ATC100B6R2BT500XT	ATC
C13, C14	12 pF Chip Capacitor	ATC800B120JT500XT	ATC
C15	0.2 pF Chip Capacitor	ATC100B0R24BT500XT	ATC
C16	0.4 pF Chip Capacitor	ATC800B0R4BT500XT	ATC
C17, C18, C19	0.5 pF Chip Capacitor	ATC100B0R5BT500XT	ATC
R1, R2	2.2 Ω , 1/8 W Chip Resistor	CRCW08052R20JNEA	Vishay
PCB	Rogers RO4350B, 0.020", $\epsilon_r = 3.66$	D81895	MTL

TYPICAL CHARACTERISTICS — 2110–2200 MHz

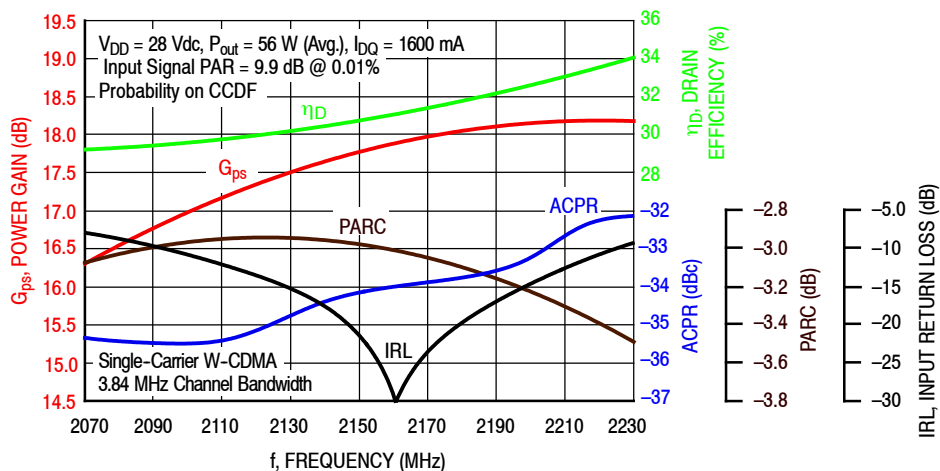


Figure 3. Single-Carrier Output Peak-to-Average Ratio Compression (PARC) Broadband Performance @ $P_{out} = 56$ Watts Avg.

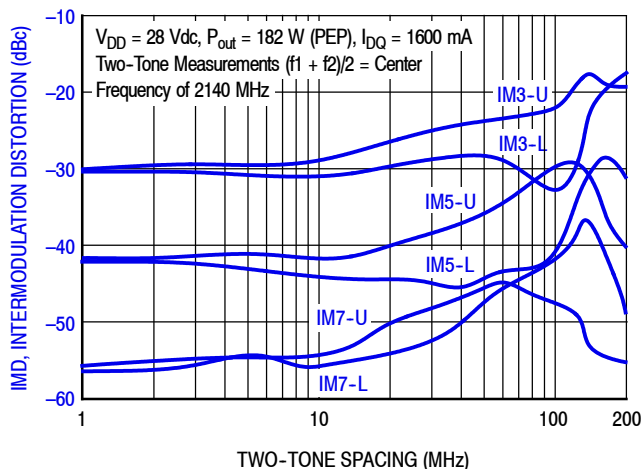


Figure 4. Intermodulation Distortion Products versus Two-Tone Spacing

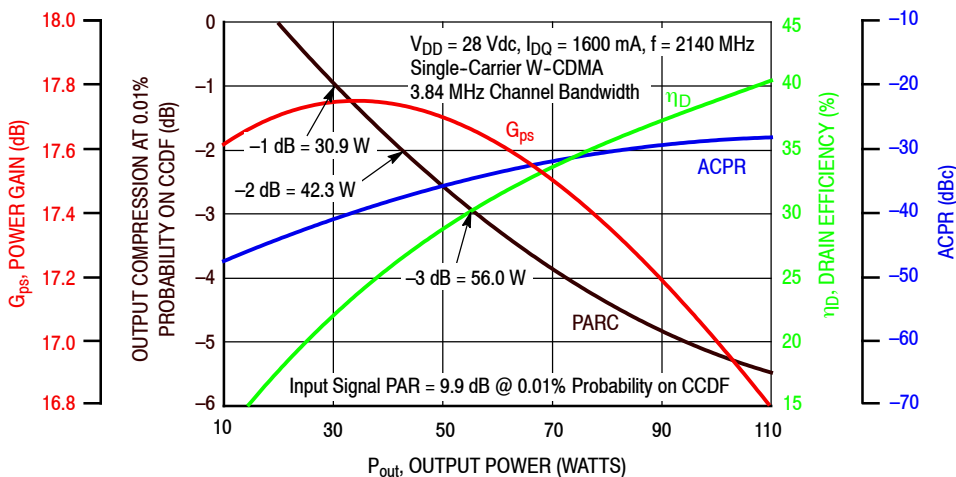


Figure 5. Output Peak-to-Average Ratio Compression (PARC) versus Output Power

TYPICAL CHARACTERISTICS — 2110–2200 MHz

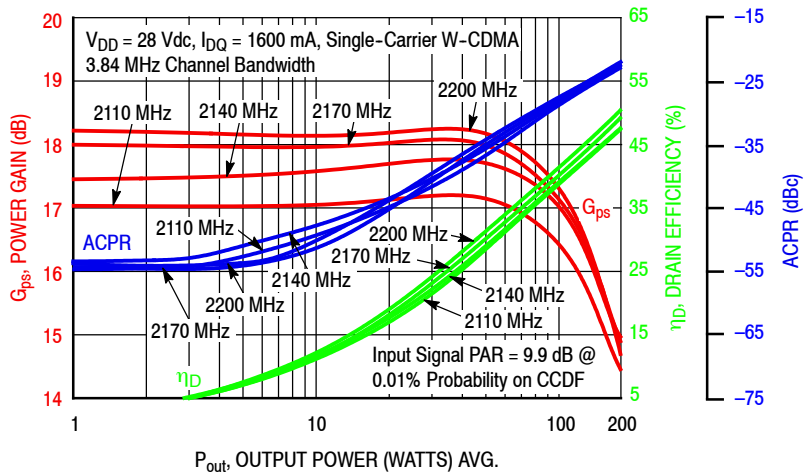


Figure 6. Single-Carrier W-CDMA Power Gain, Drain Efficiency and ACPR versus Output Power

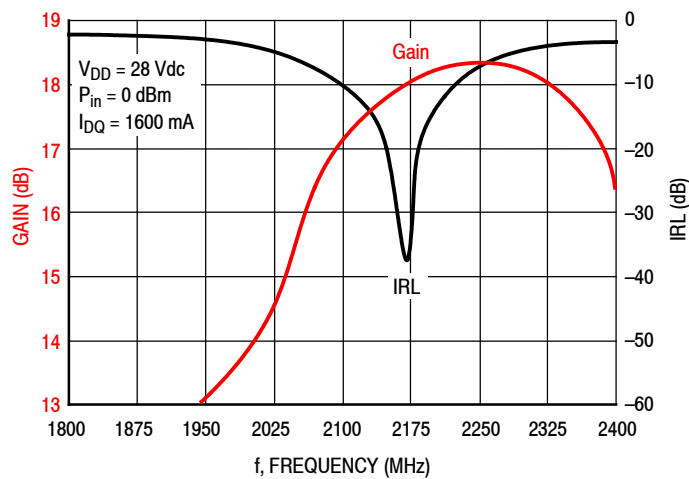


Figure 7. Broadband Frequency Response

Table 8. Load Pull Performance — Maximum Power Tuning

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 1607 \text{ mA}$, Pulsed CW, 10 $\mu\text{sec(on)}$, 10% Duty Cycle

f (MHz)	$Z_{\text{source}} (\Omega)$	$Z_{\text{in}} (\Omega)$	Max Output Power					
			P1dB					
			$Z_{\text{load}}^{(1)} (\Omega)$	Gain (dB)	(dBm)	(W)	η_D (%)	AM/PM (°)
2110	0.82 – j4.10	0.86 + j3.79	0.62 – j3.93	16.5	54.9	311	54.3	–11
2140	0.95 – j4.36	1.04 + j3.98	0.63 – j4.00	16.8	54.9	311	54.8	–11
2170	1.08 – j4.63	1.19 + j4.22	0.62 – j4.03	16.6	54.8	302	52.8	–12
2200	1.32 – j5.00	1.40 + j4.48	0.57 – j3.99	16.7	54.7	294	51.3	–12

f (MHz)	$Z_{\text{source}} (\Omega)$	$Z_{\text{in}} (\Omega)$	Max Output Power					
			P3dB					
			$Z_{\text{load}}^{(2)} (\Omega)$	Gain (dB)	(dBm)	(W)	η_D (%)	AM/PM (°)
2110	0.82 – j4.10	0.82 + j3.91	0.63 – j4.03	14.3	55.7	368	54.9	–15
2140	0.95 – j4.36	0.99 + j4.13	0.62 – j4.06	14.6	55.6	366	55.1	–16
2170	1.08 – j4.63	1.15 + j4.39	0.62 – j4.09	14.4	55.5	356	53.5	–16
2200	1.32 – j5.00	1.41 + j4.68	0.59 – j4.19	14.1	55.4	343	50.1	–16

(1) Load impedance for optimum P1dB power.

(2) Load impedance for optimum P3dB power.

Z_{source} = Measured impedance presented to the input of the device at the package reference plane.

Z_{in} = Impedance as measured from gate contact to ground.

Z_{load} = Measured impedance presented to the output of the device at the package reference plane.

Table 9. Load Pull Performance — Maximum Efficiency Tuning

$V_{DD} = 28 \text{ Vdc}$, $I_{DQ} = 1607 \text{ mA}$, Pulsed CW, 10 $\mu\text{sec(on)}$, 10% Duty Cycle

f (MHz)	$Z_{\text{source}} (\Omega)$	$Z_{\text{in}} (\Omega)$	Max Drain Efficiency					
			P1dB					
			$Z_{\text{load}}^{(1)} (\Omega)$	Gain (dB)	(dBm)	(W)	η_D (%)	AM/PM (°)
2110	0.82 – j4.10	0.81 + j3.85	1.07 – j3.18	19.4	52.9	196	66.0	–19
2140	0.95 – j4.36	0.97 + j4.04	1.01 – j3.30	19.4	53.2	207	66.1	–19
2170	1.08 – j4.63	1.14 + j4.30	0.94 – j3.32	19.2	53.0	199	63.6	–19
2200	1.32 – j5.00	1.35 + j4.54	0.89 – j3.29	19.5	52.6	183	62.6	–20

f (MHz)	$Z_{\text{source}} (\Omega)$	$Z_{\text{in}} (\Omega)$	Max Drain Efficiency					
			P3dB					
			$Z_{\text{load}}^{(2)} (\Omega)$	Gain (dB)	(dBm)	(W)	η_D (%)	AM/PM (°)
2110	0.82 – j4.10	0.75 + j3.93	1.00 – j3.27	17.1	53.8	242	66.2	–25
2140	0.95 – j4.36	0.91 + j4.16	0.99 – j3.30	17.4	53.7	237	65.9	–26
2170	1.08 – j4.63	1.09 + j4.43	0.93 – j3.35	17.1	53.7	233	63.1	–26
2200	1.32 – j5.00	1.33 + j4.70	0.90 – j3.44	17.2	53.7	237	62.2	–25

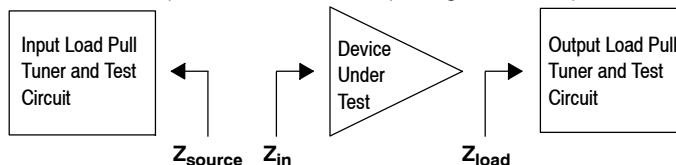
(1) Load impedance for optimum P1dB efficiency.

(2) Load impedance for optimum P3dB efficiency.

Z_{source} = Measured impedance presented to the input of the device at the package reference plane.

Z_{in} = Impedance as measured from gate contact to ground.

Z_{load} = Measured impedance presented to the output of the device at the package reference plane.



A2T21S260W12NR3

P1dB – TYPICAL LOAD PULL CONTOURS — 2140 MHz

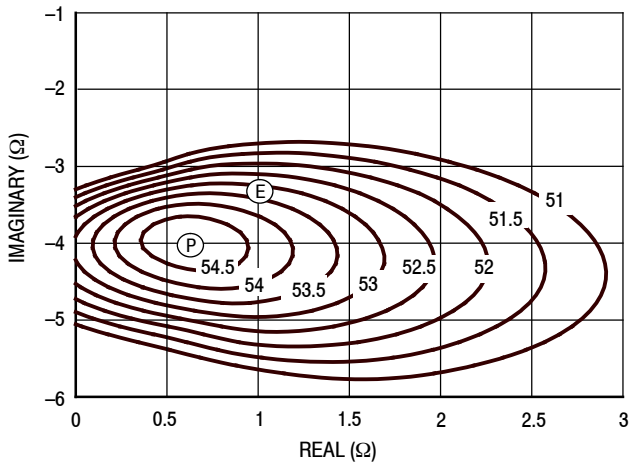


Figure 8. P1dB Load Pull Output Power Contours (dBm)

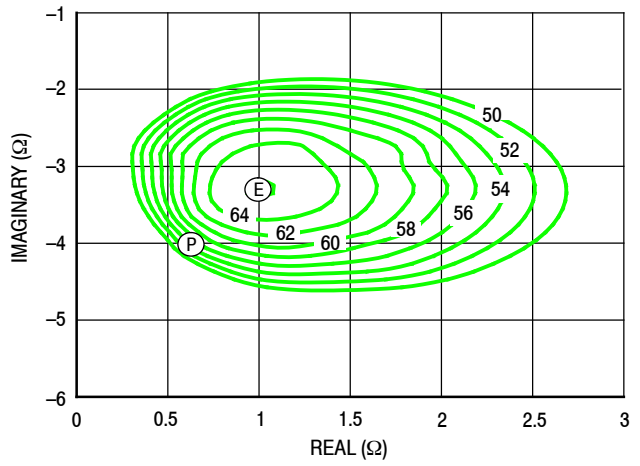


Figure 9. P1dB Load Pull Efficiency Contours (%)

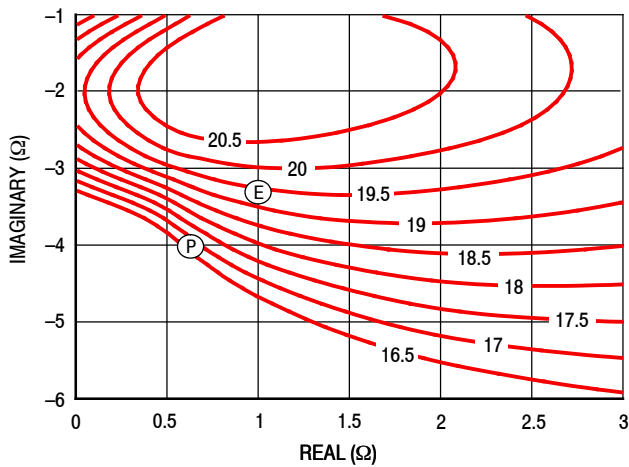


Figure 10. P1dB Load Pull Gain Contours (dB)

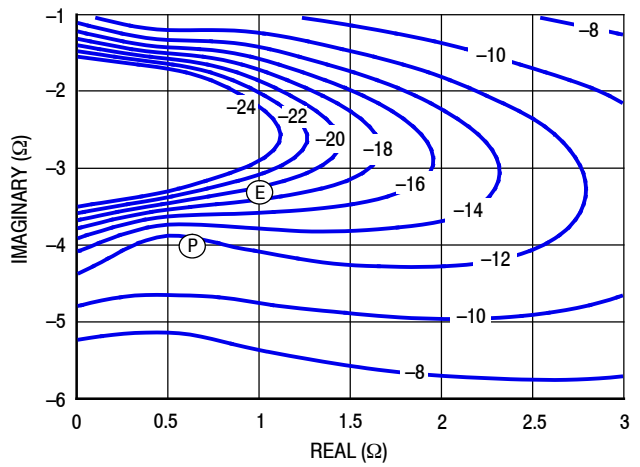


Figure 11. P1dB Load Pull AM/PM Contours (°)

NOTE: (P) = Maximum Output Power
(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

P3dB – TYPICAL LOAD PULL CONTOURS — 2140 MHz

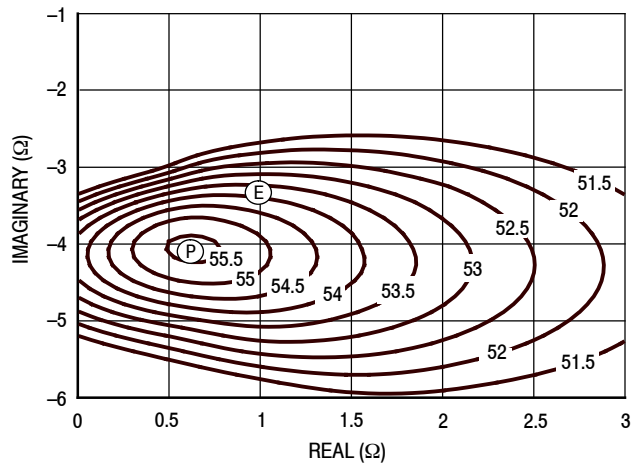


Figure 12. P3dB Load Pull Output Power Contours (dBm)

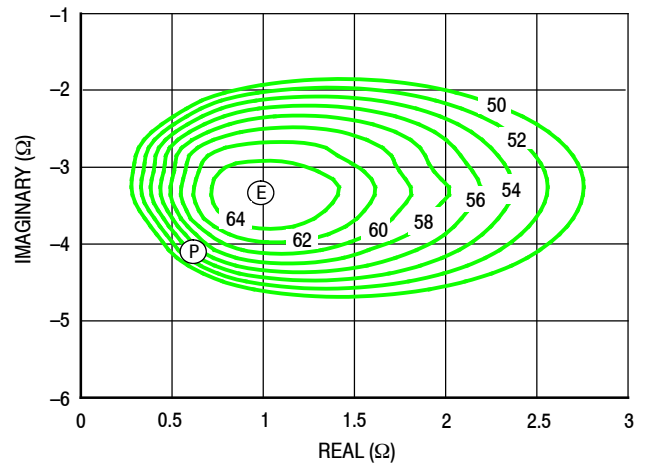


Figure 13. P3dB Load Pull Efficiency Contours (%)

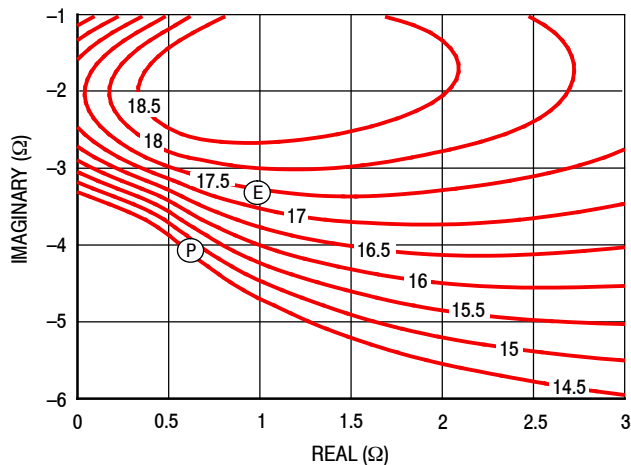


Figure 14. P3dB Load Pull Gain Contours (dB)

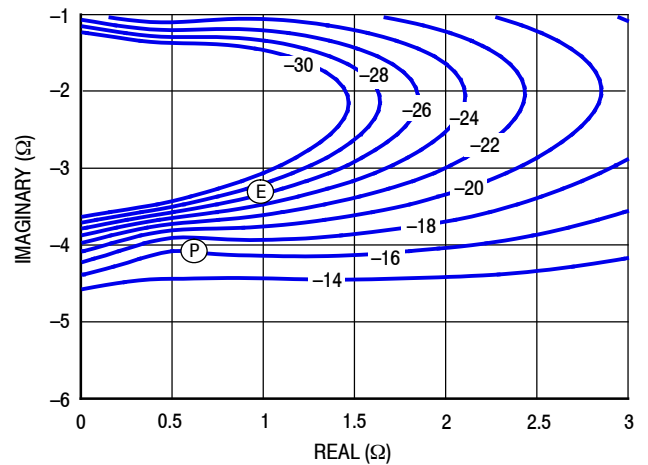
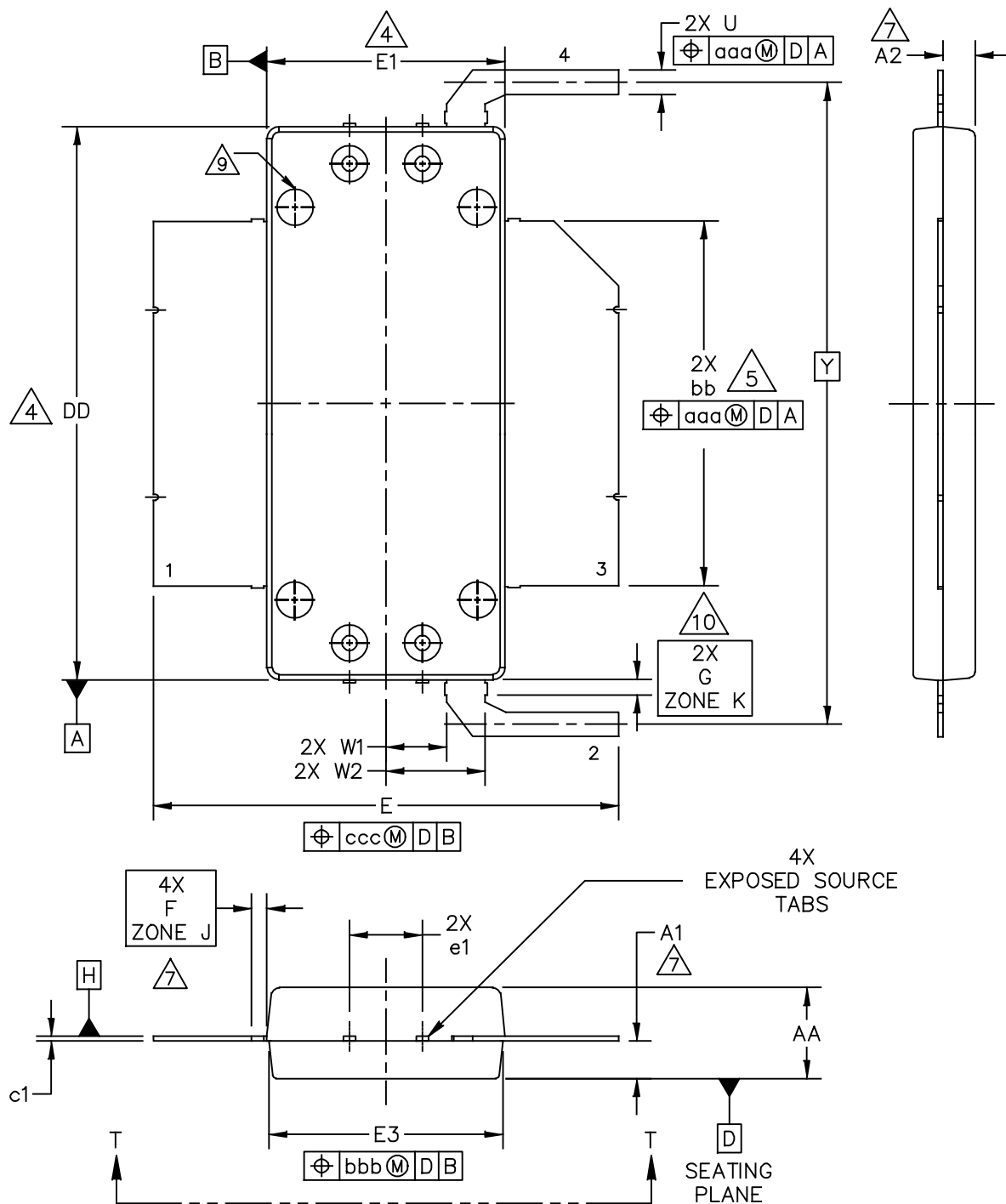


Figure 15. P3dB Load Pull AM/PM Contours (°)

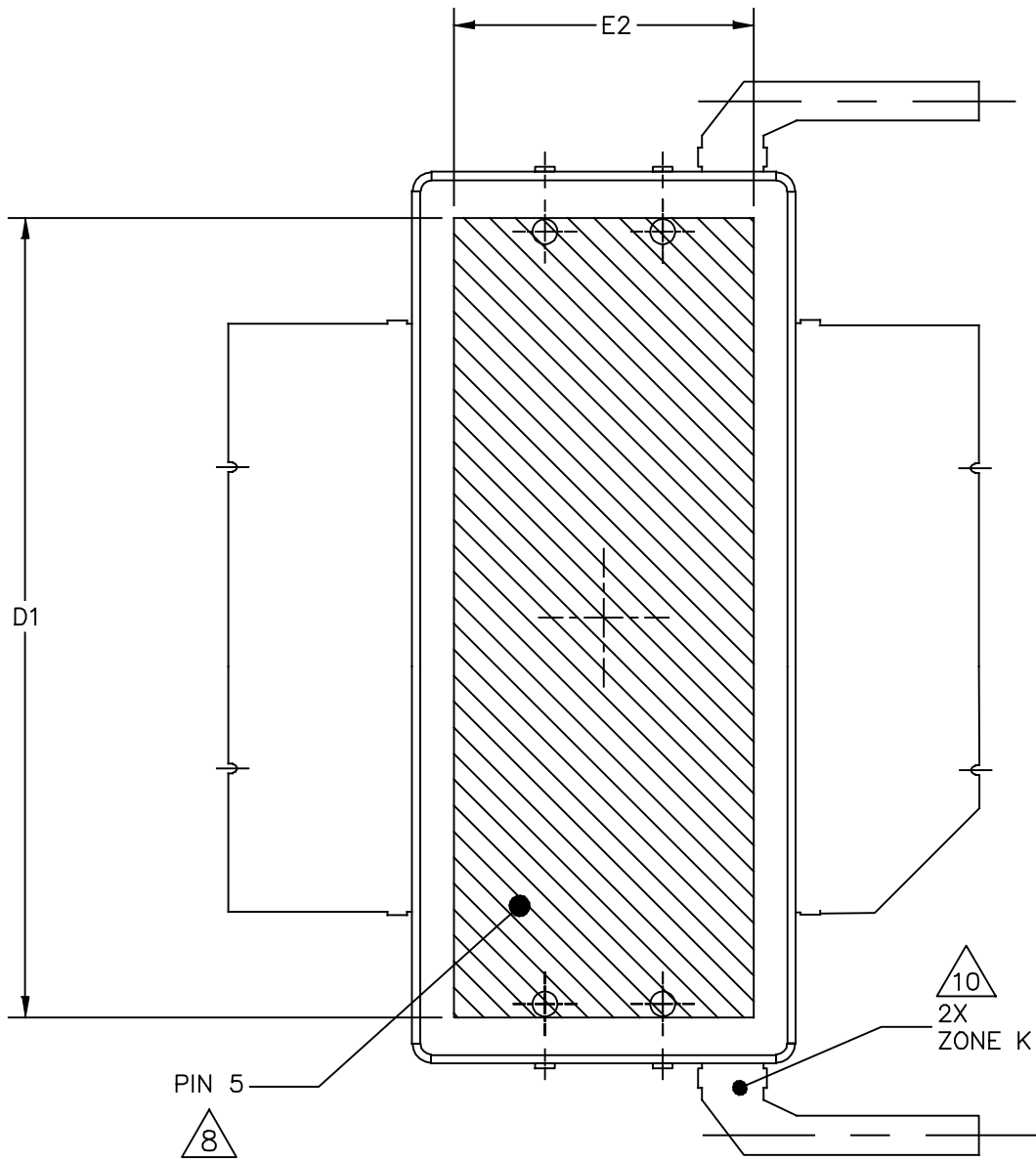
NOTE: (P) = Maximum Output Power
(E) = Maximum Drain Efficiency

- Gain
- Drain Efficiency
- Linearity
- Output Power

PACKAGE DIMENSIONS



© NXP SEMICONDUCTORS N.V. ALL RIGHTS RESERVED	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE
TITLE: OM-880X-2L2L	DOCUMENT NO: 98ASA00549D	REV: A
	STANDARD: NON-JEDEC	
	SOT1817-1	09 FEB 2016



BOTTOM VIEW
VIEW T-T

© NXP SEMICONDUCTORS N.V. ALL RIGHTS RESERVED	MECHANICAL OUTLINE	PRINT VERSION NOT TO SCALE	
TITLE: OM-880X-2L2L		DOCUMENT NO: 98ASA00549D	REV: A
		STANDARD: NON-JEDEC	
		SOT1817-1	09 FEB 2016

NOTES:

1. CONTROLLING DIMENSION: INCH
2. INTERPRET DIMENSIONS AND TOLERANCES PER ASME Y14.5M-1994.
3. DATUM PLANE H IS LOCATED AT TOP OF LEAD AND IS COINCIDENT WITH THE LEAD WHERE THE LEAD EXITS THE PLASTIC BODY AT THE TOP OF THE PARTING LINE.
4. DIMENSIONS DD AND E1 DO NOT INCLUDE MOLD PROTRUSION. ALLOWABLE PROTRUSION IS .006 INCH (0.15 MM) PER SIDE. DIMENSIONS DD AND E1 DO INCLUDE MOLD MISMATCH AND ARE DETERMINED AT DATUM PLANE H.
5. DIMENSION bb DOES NOT INCLUDE DAMBAR PROTRUSION. ALLOWABLE DAMBAR PROTRUSION SHALL BE .005 INCH (0.13 MM) TOTAL IN EXCESS OF THE bb DIMENSION AT MAXIMUM MATERIAL CONDITION.
6. DATUMS A AND B TO BE DETERMINED AT DATUM PLANE H.
7. DIMENSIONS A1 AND A2 APPLIES WITHIN ZONE J ONLY. A1 APPLIES TO PINS 1 AND 3. A2 APPLIES TO PINS 2 AND 4.
8. HATCHING REPRESENTS THE EXPOSED AREA OF THE HEAT SLUG. THE DIMENSIONS D1 AND E2 REPRESENT THE VALUES BETWEEN THE TWO OPPOSITE POINTS ALONG THE EDGES OF EXPOSED AREA OF HEAT SLUG.
9. DIMPLED HOLE REPRESENTS INPUT SIDE.
10. ZONE K REPRESENTS NON-SOLDERABLE REGION WHERE MOLD FLASH AND RESIN BLEED ARE PERMITTED ON BOTH SIDES OF THE LEADS.

DIM	INCH		MILLIMETER		DIM	INCH		MILLIMETER	
	MIN	MAX	MIN	MAX		MIN	MAX	MIN	MAX
AA	.148	.152	3.76	3.86	W1	.095	.105	2.41	2.67
A1	.059	.065	1.50	1.65	W2	.158	.168	4.01	4.27
A2	.056	.068	1.42	1.73	U	.037	.043	0.94	1.09
DD	.908	.912	23.06	23.16	Y	1.056 BSC		26.82 BSC	
D1	.816	----	20.73	----	bb	.597	.603	15.16	15.32
E	.762	.770	19.35	19.56	c1	.007	.011	0.18	0.28
E1	.390	.394	9.91	10.01	e1	.116	.124	2.95	3.15
E2	.306	----	7.77	----					
E3	.383	.387	9.73	9.83	aaa	.004		0.10	
F	.025 BSC		0.64 BSC		bbb	.006		0.15	
G	.030 BSC		0.76 BSC		ccc	.010		0.25	

© NXP SEMICONDUCTORS N.V. ALL RIGHTS RESERVED		MECHANICAL OUTLINE		PRINT VERSION NOT TO SCALE			
TITLE: OM-880X-2L2L			DOCUMENT NO: 98ASA00549D		REV: A		
			STANDARD: NON-JEDEC				
			SOT1817-1		09 FEB 2016		

PRODUCT DOCUMENTATION, SOFTWARE AND TOOLS

Refer to the following resources to aid your design process.

Application Notes

- AN1907: Solder Reflow Attach Method for High Power RF Devices in Over-Molded Plastic Packages
- AN1955: Thermal Measurement Methodology of RF Power Amplifiers

Engineering Bulletins

- EB212: Using Data Sheet Impedances for RF LDMOS Devices

Software

- Electromigration MTTF Calculator
- RF High Power Model
- .s2p File

Development Tools

- Printed Circuit Boards

To Download Resources Specific to a Given Part Number:

1. Go to <http://www.nxp.com/RF>
2. Search by part number
3. Click part number link
4. Choose the desired resource from the drop down menu

REVISION HISTORY

The following table summarizes revisions to this document.

Revision	Date	Description
0	Jan. 2017	<ul style="list-style-type: none">• Initial release of data sheet

How to Reach Us:

Home Page:
nxp.com

Web Support:
nxp.com/support

Information in this document is provided solely to enable system and software implementers to use NXP products. There are no express or implied copyright licenses granted hereunder to design or fabricate any integrated circuits based on the information in this document. NXP reserves the right to make changes without further notice to any products herein.

NXP makes no warranty, representation, or guarantee regarding the suitability of its products for any particular purpose, nor does NXP assume any liability arising out of the application or use of any product or circuit, and specifically disclaims any and all liability, including without limitation consequential or incidental damages. "Typical" parameters that may be provided in NXP data sheets and/or specifications can and do vary in different applications, and actual performance may vary over time. All operating parameters, including "typicals," must be validated for each customer application by customer's technical experts. NXP does not convey any license under its patent rights nor the rights of others. NXP sells products pursuant to standard terms and conditions of sale, which can be found at the following address: nxp.com/SalesTermsandConditions.

NXP, the NXP logo, Freescale, the Freescale logo, and Airfast are trademarks of NXP B.V. All other product or service names are the property of their respective owners.
© 2017 NXP B.V.



Компания «Океан Электроники» предлагает заключение долгосрочных отношений при поставках импортных электронных компонентов на взаимовыгодных условиях!

Наши преимущества:

- Поставка оригинальных импортных электронных компонентов напрямую с производств Америки, Европы и Азии, а так же с крупнейших складов мира;
- Широкая линейка поставок активных и пассивных импортных электронных компонентов (более 30 млн. наименований);
- Поставка сложных, дефицитных, либо снятых с производства позиций;
- Оперативные сроки поставки под заказ (от 5 рабочих дней);
- Экспресс доставка в любую точку России;
- Помощь Конструкторского Отдела и консультации квалифицированных инженеров;
- Техническая поддержка проекта, помощь в подборе аналогов, поставка прототипов;
- Поставка электронных компонентов под контролем ВП;
- Система менеджмента качества сертифицирована по Международному стандарту ISO 9001;
- При необходимости вся продукция военного и аэрокосмического назначения проходит испытания и сертификацию в лаборатории (по согласованию с заказчиком);
- Поставка специализированных компонентов военного и аэрокосмического уровня качества (Xilinx, Altera, Analog Devices, Intersil, Interpoint, Microsemi, Actel, Aeroflex, Peregrine, VPT, Syfer, Eurofarad, Texas Instruments, MS Kennedy, Miteq, Cobham, E2V, MA-COM, Hittite, Mini-Circuits, General Dynamics и др.);

Компания «Океан Электроники» является официальным дистрибьютором и эксклюзивным представителем в России одного из крупнейших производителей разъемов военного и аэрокосмического назначения «JONHON», а так же официальным дистрибьютором и эксклюзивным представителем в России производителя высокотехнологичных и надежных решений для передачи СВЧ сигналов «FORSTAR».



JONHON

«JONHON» (основан в 1970 г.)

Разъемы специального, военного и аэрокосмического назначения:

(Применяются в военной, авиационной, аэрокосмической, морской, железнодорожной, горно- и нефтедобывающей отраслях промышленности)

«FORSTAR» (основан в 1998 г.)

ВЧ соединители, коаксиальные кабели,
кабельные сборки и микроволновые компоненты:

(Применяются в телекоммуникациях гражданского и специального назначения, в средствах связи, РЛС, а так же военной, авиационной и аэрокосмической отраслях промышленности).



Телефон: 8 (812) 309-75-97 (многоканальный)

Факс: 8 (812) 320-03-32

Электронная почта: ocean@oceanchips.ru

Web: <http://oceanchips.ru/>

Адрес: 198099, г. Санкт-Петербург, ул. Калинина, д. 2, корп. 4, лит. А